

**Notice of References Cited**

Application/Control No.

09/665,715

Applicant(s)/Patent Under  
Reexamination  
SCHEEL ET AL.

Examiner

Kim T. Huynh

Art Unit

2189

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,408,355	06-2002	Toguchi, Kazunobu	710/314
	B	US-6,434,649	08-2002	Baker et al.	710/107
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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